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8019-1028

PATENTS
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TECHNOLOGY CENTER 2800

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Yutaka TAKEISHI et al.

Confirmation No. 2596

Serial No. 09/801,900

Group 2871

Filed March 9, 2001

Examiner J. Di Grazio

SIGNAL PROCESSING CIRCUIT SUBSTRATE
USED FOR LIQUID CRYSTAL DISPLAY UNIT
AND METHOD OF ASSEMBLING THE SAME

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents

Washington, D.C. 20231

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, the accompanying document, a copy of which is attached to this statement, is made of record on the enclosed sheet.

A concise explanation of the relevance of this item is that this reference was cited by the Korean Patent Office in an Office Action. A copy of the Korean Office Action, along with a Japanese translation, in which it was cited is attached hereto, with what is believed to be the pertinent portion enclosed in a wavy line. An English translation of the enclosed portion is also attached hereto.

Under the provisions of 37 CFR 1.97(e), the undersigned hereby certifies that each item of information contained in this Information Disclosure Statement was first cited in any communication from a foreign Patent Office in a

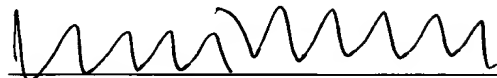
TAKEISHI et al. S.N. 09/801,900

counterpart foreign application not more than three months
prior to the filing of this Statement.

Respectfully submitted,

YOUNG & THOMPSON

By

A handwritten signature in black ink, appearing to read 'Robert J. Patch', written over a horizontal line.

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April 25, 2003

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
8019-1028

SERIAL NO.
09/801,900

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

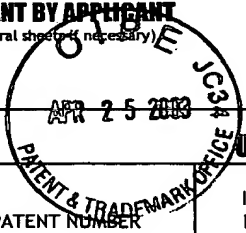
(Use several sheets if necessary)

37 CFR 1.98(b)

APPLICANT
Yutaka TAKEISHI et al.

FILING DATE
March 9, 2001

GROUP
2871



U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
	AJ	6-214212 /	08/94	JAPAN			
	AK						
	AL						
	AM						
	AN						

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

	AO	
	AP	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.